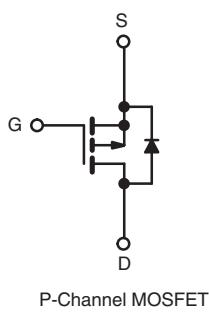


## Power MOSFET

PRODUCT SUMMARY	
V <sub>DS</sub> (V)	- 60
R <sub>D(S(on))</sub> (Ω)	V <sub>GS</sub> = - 10 V      0.50
Q <sub>g</sub> (Max.) (nC)	12
Q <sub>gs</sub> (nC)	3.8
Q <sub>gd</sub> (nC)	5.1
Configuration	Single



### FEATURES

- Halogen-free According to IEC 61249-2-21  
Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- Fast Switching
- Ease of Parallelizing
- Compliant to RoHS Directive 2002/95/EC



### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOT-223 package is designed for surface-mounting using vapor phase, infrared, or wave soldering techniques. Its unique package design allows for easy automatic pick-and-place as with other SOT or SOIC packages but has the added advantage of improved thermal performance due to an enlarged tab for heatsinking. Power dissipation of greater than 1.25 W is possible in a typical surface mount application.

### ORDERING INFORMATION

Package	SOT-223	SOT-223
Lead (Pb)-free and Halogen-free	SiHFL9014-GE3	-
Lead (Pb)-free	IRFL9014PbF	IRFL9014TRPbF <sup>a</sup>
	SiHFL9014-E3	SiHFL9014T-E3 <sup>a</sup>
SnPb	IRFL9014	IRFL9014TR <sup>a</sup>
	SiHFL9014	SiHFL9014T <sup>a</sup>

#### Note

a. See device orientation.

### ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>DS</sub>	- 60	V
Gate-Source Voltage	V <sub>GS</sub>	± 20	
Continuous Drain Current	V <sub>GS</sub> at - 10 V	T <sub>C</sub> = 25 °C	A
		T <sub>C</sub> = 100 °C	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	- 1.8	W/°C
Linear Derating Factor		- 1.1	
Linear Derating Factor (PCB Mount) <sup>b</sup>		- 14	mJ
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	0.025	
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	0.017	A
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	140	mJ

\* Pb containing terminations are not RoHS compliant, exemptions may apply

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_C = 25^\circ\text{C}$ , unless otherwise noted)				
PARAMETER	SYMBOL		LIMIT	UNIT
Maximum Power Dissipation	$P_D$		3.1	W
Maximum Power Dissipation (PCB Mount) <sup>e</sup>			2.0	
Peak Diode Recovery $dV/dt^c$			$dV/dt$	- 4.5
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$		- 55 to + 150	$^\circ\text{C}$
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = - 25 \text{ V}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 50 \text{ mH}$ ,  $R_g = 25 \Omega$ ,  $I_{AS} = - 1.8 \text{ A}$  (see fig. 12).
- c.  $I_{SD} \leq - 6.7 \text{ A}$ ,  $dI/dt \leq 90 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150^\circ\text{C}$ .
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

<b>THERMAL RESISTANCE RATINGS</b>				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	$R_{thJA}$	-	60	$^\circ\text{C}/\text{W}$
Maximum Junction-to-Case (Drain)	$R_{thJC}$	-	40	

**Note**

- a. When mounted on 1" square PCB (FR-4 or G-10 material).

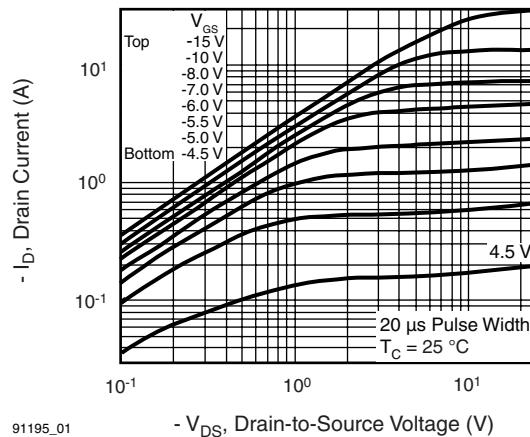
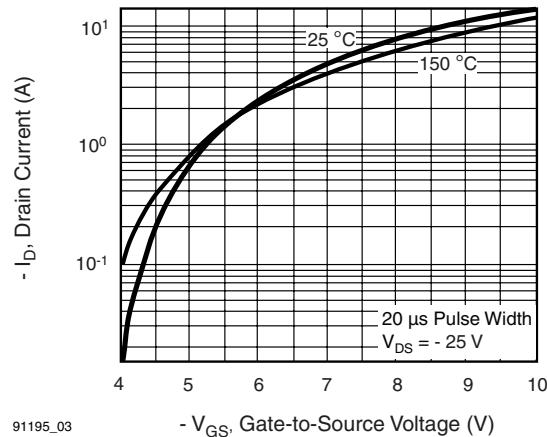
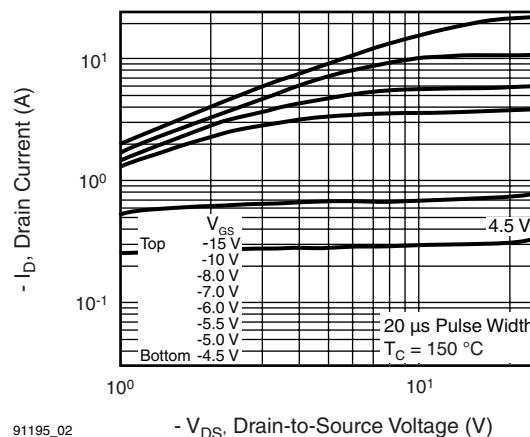
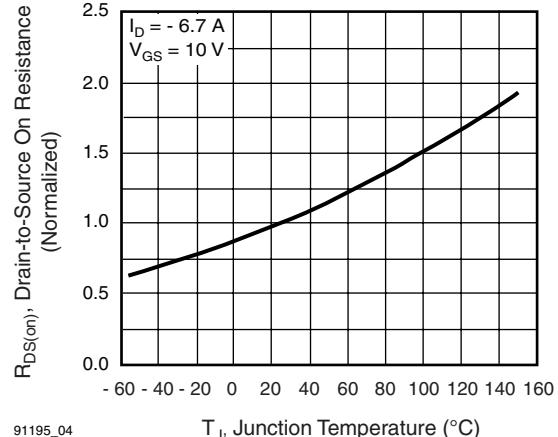
<b>SPECIFICATIONS</b> ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$		- 60	-	-	V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference to $25^\circ\text{C}$ , $I_D = 1 \text{ mA}$		-	- 0.059	-	$^\circ\text{C}/\text{V}$
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$		- 2.0	-	- 4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$		-	-	$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = - 60 \text{ V}$ , $V_{GS} = 0 \text{ V}$		-	-	- 100	$\mu\text{A}$
		$V_{DS} = - 48 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $T_J = 125^\circ\text{C}$		-	-	- 500	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = - 10 \text{ V}$	$I_D = 1.1 \text{ A}^b$	-	-	0.50	$\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS} = - 25 \text{ V}$	$I_D = 1.1 \text{ A}^b$	1.3	-	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1.0 \text{ MHz}$ , see fig. 5		-	270	-	pF
Output Capacitance	$C_{oss}$			-	170	-	
Reverse Transfer Capacitance	$C_{rss}$			-	31	-	
Total Gate Charge	$Q_g$	$V_{GS} = - 10 \text{ V}$	$I_D = - 6.7 \text{ A}$ , $V_{DS} = - 48 \text{ V}$ , see fig. 6 and 13 <sup>b</sup>	-	-	12	nC
Gate-Source Charge	$Q_{gs}$			-	-	3.8	
Gate-Drain Charge	$Q_{gd}$			-	-	5.1	
Turn-On Delay Time	$t_{d(on)}$			-	11	-	
Rise Time	$t_r$	$V_{DD} = - 30 \text{ V}$ , $I_D = - 6.7 \text{ A}$ , $R_g = 24 \Omega$ , $R_D = 4.0 \Omega$ , see fig. 10 <sup>b</sup>		-	63	-	ns
Turn-Off Delay Time	$t_{d(off)}$			-	9.6	-	
Fall Time	$t_f$			-	31	-	
Internal Drain Inductance	$L_D$			-	4.0	-	nH
Internal Source Inductance	$L_S$	Between lead, 6 mm (0.25") from package and center of die contact		-	6.0	-	

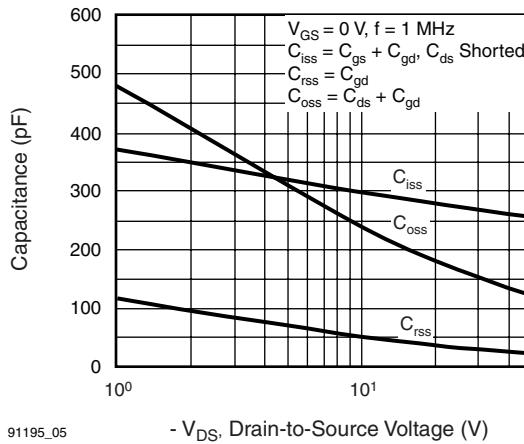
**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode	-	-	- 1.8	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$		-	-	- 14	
Body Diode Voltage	$V_{SD}$	$T_J = 25^\circ\text{C}, I_S = - 1.8 \text{ A}, V_{GS} = 0 \text{ V}^b$	-	-	- 5.5	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ\text{C}, I_F = - 6.7 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$	-	80	160	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	0.096	0.19	$\mu\text{C}$
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )				

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).  
b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .

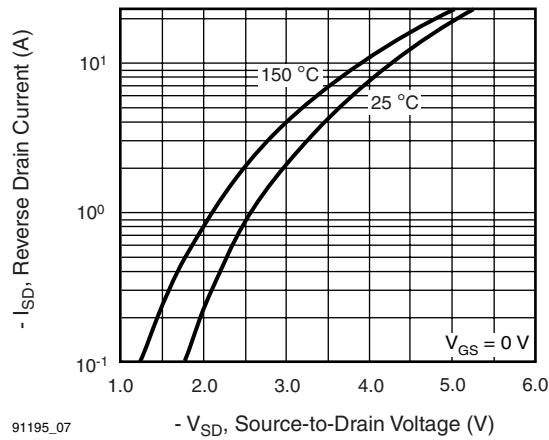
**TYPICAL CHARACTERISTICS** ( $25^\circ\text{C}$ , unless otherwise noted)

**Fig. 1 - Typical Output Characteristics,  $T_C = 25^\circ\text{C}$** 

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics,  $T_C = 150^\circ\text{C}$** 

**Fig. 4 - Normalized On-Resistance vs. Temperature**



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 $- V_{DS}$ , Drain-to-Source Voltage (V)

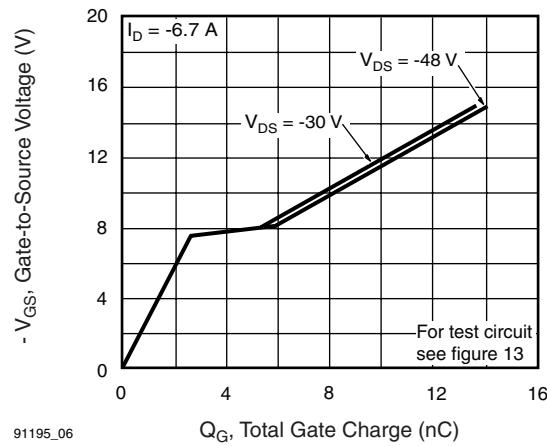
Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



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 $- V_{SD}$ , Source-to-Drain Voltage (V)

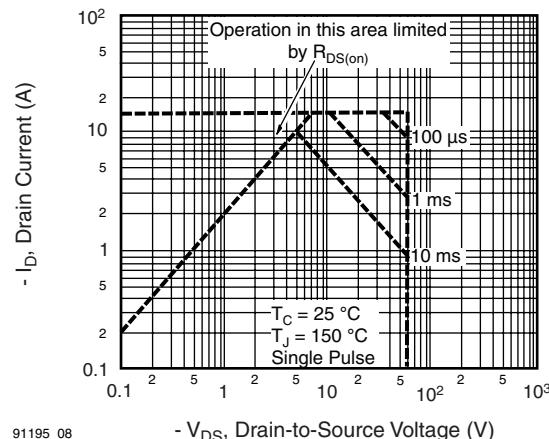
Fig. 7 - Typical Source-Drain Diode Forward Voltage



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 $Q_G$ , Total Gate Charge (nC)

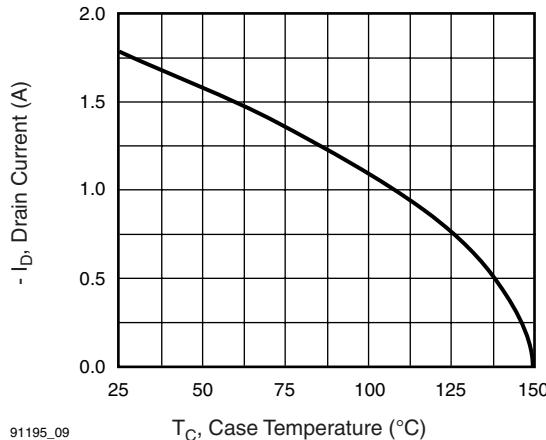
Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



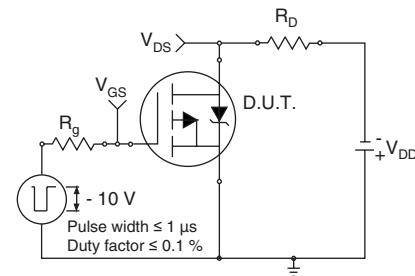
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 $- V_{DS}$ , Drain-to-Source Voltage (V)

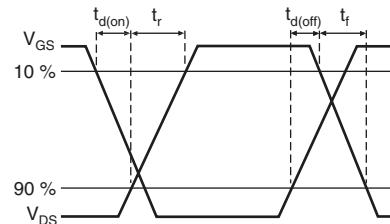
Fig. 8 - Maximum Safe Operating Area



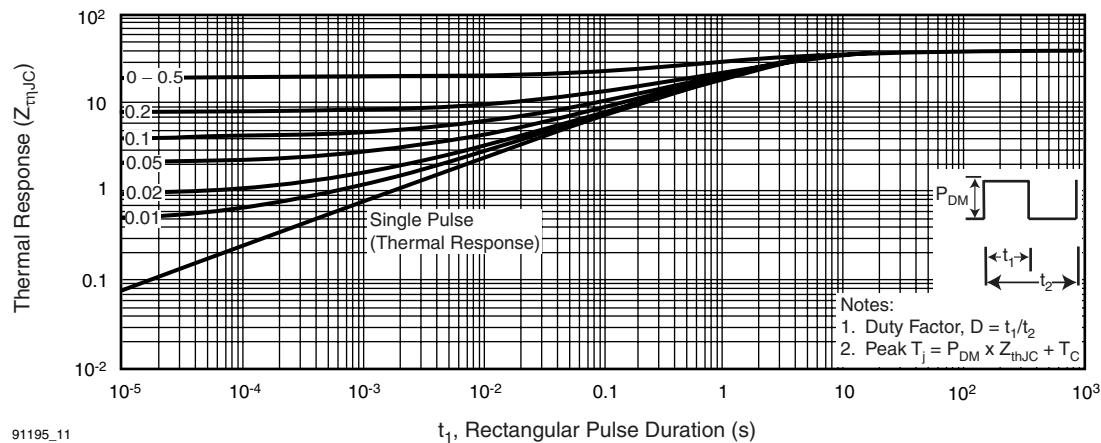
**Fig. 9 - Maximum Drain Current vs. Case Temperature**



**Fig. 10a - Switching Time Test Circuit**



**Fig. 10b - Switching Time Waveforms**



**Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**

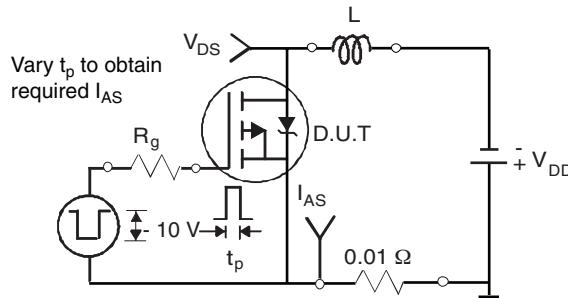


Fig. 12a - Unclamped Inductive Test Circuit

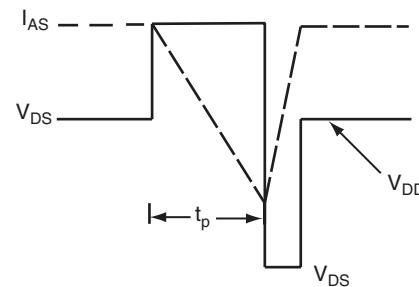


Fig. 12b - Unclamped Inductive Waveforms

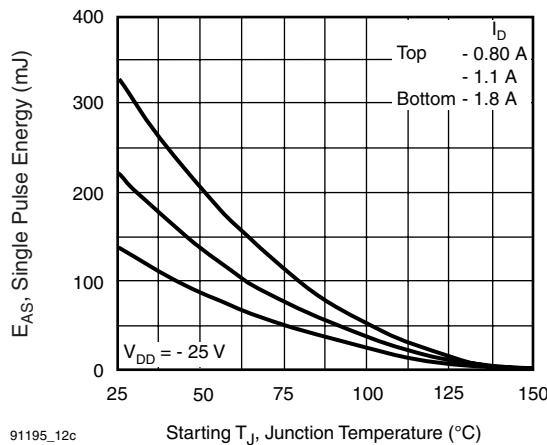


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

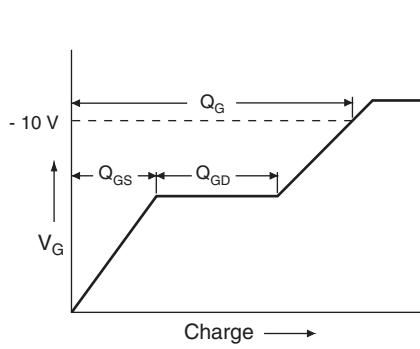


Fig. 13a - Basic Gate Charge Waveform

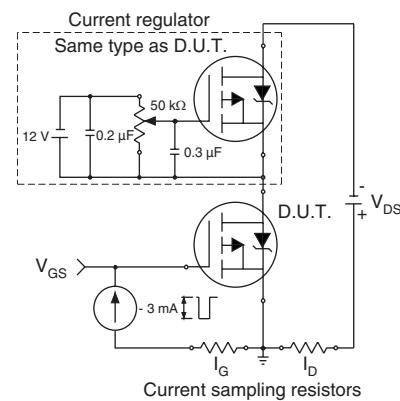
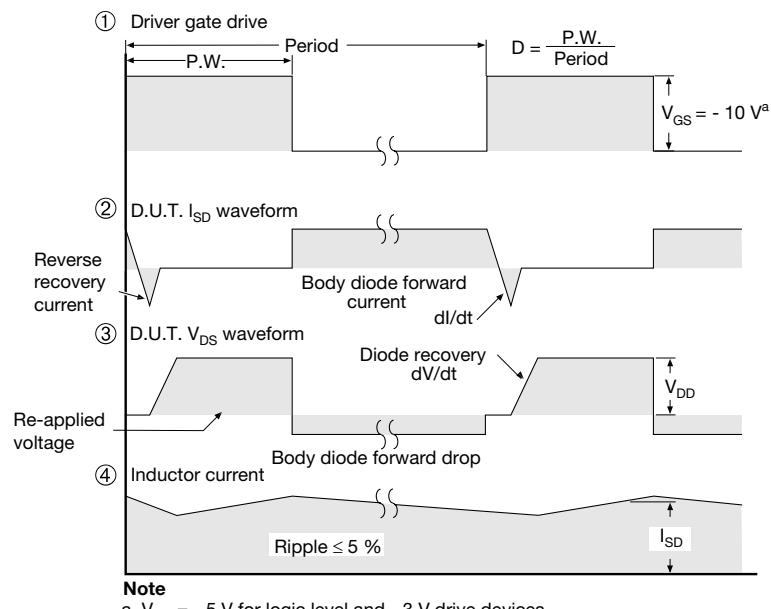
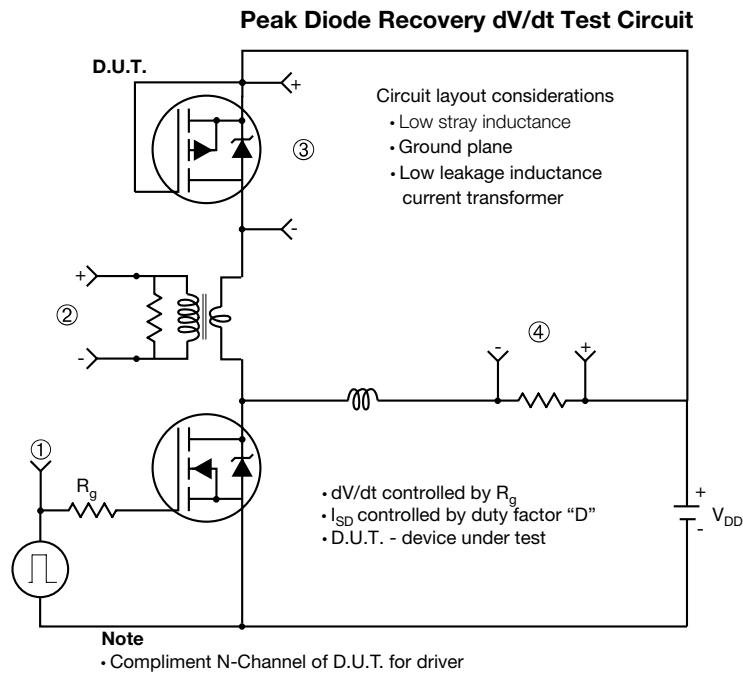


Fig. 13b - Gate Charge Test Circuit


**Fig.14 - For P-Channel**

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